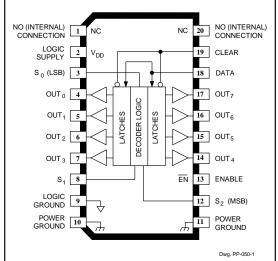
# 6B259

# **PRODUCT PREVIEW**

(Subject to change without notice) January 5, 1999



Note that the A6B259KA (DIP) and the A6B259KLW (SOIC) are electrically identical and share a common terminal number assignment.

#### ABSOLUTE MAXIMUM RATINGS at $T_A = 25^{\circ}C$

$at T_A = 25 C$
Output Voltage, $V_0$
Output Drain Current,
Continuous, I <sub>O</sub> 150 mA*
Peak, I <sub>OM</sub> 500 mA <sup>+</sup>
Single-Pulse Avalanche Energy,
E <sub>AS</sub> <b>30 mJ</b>
Logic Supply Voltage, V <sub>DD</sub> 7.0 V
Input Voltage Range,
V <sub>1</sub> 0.3 V to +7.0 V
Package Power Dissipation,
P <sub>D</sub> See Graph
Operating Temperature Range,
$T_{A}$
Storage Temperature Range,
$T_{\rm S}$
* Each output, all outputs on.
† Pulse duration $\leq 100 \mu$ s, duty cycle $\leq 2\%$ .
Caution: These CMOS devices have input static

*Caution: These CMOS devices have input static protection (Class 3) but are still susceptible to damage if exposed to extremely high static electrical charges.* 

# 8-BIT ADDRESSABLE DMOS POWER DRIVER

The A6B259KA and A6B259KLW combine a 3-to-8 line CMOS decoder and accompanying data latches, control circuitry, and DMOS outputs in a multi-functional power driver capable of storing single-line data in the addressable latches or use as a decoder or demuliplexer. Driver applications include relays, solenoids, and other medium-current or high-voltage peripheral power loads.

The CMOS inputs and latches allow direct interfacing with microprocessor-based systems. Use with TTL may require appropriate pullup resistors to ensure an input logic high. Four modes of operation are selectable with the CLEAR and ENABLE inputs.

The A6B259KA/KLW DMOS open-drain outputs are capable of sinking up to 500 mA. Similar devices with reduced  $r_{DS(on)}$  will be available as the A6259.

The A6B259KA is furnished in a 20-pin dual in-line plastic package. The A6B259KLW is furnished in a 20-lead wide-body, small-outline plastic package (SOIC) with gull-wing leads for surface-mount applications. Copper lead frames, reduced supply current requirements, and low on-state resistance allow either device to sink 150 mA from all outputs continuously, to ambient temperatures greater than 85°C.

### FEATURES

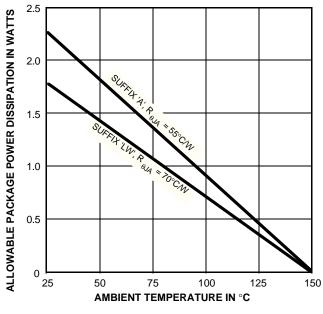
- 50 V Minimum Output Clamp Voltage
- 150 mA Output Current (all outputs simultaneously)
- **5** Ω Typical  $r_{DS(on)}$
- Low Power Consumption
- Replacements for TPIC6B259N and TPIC6B259DW

This document contains information on a product under development. Allegro MicroSystems, Inc. reserves the right to change or discontinue this product without notice.

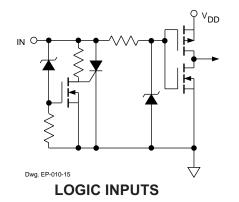
Always order by complete part number:

Part Number	Package	$R_{\theta JA}$	$R_{\theta JC}$
A6B259KA	20-pin DIP	55°C/W	25°C/W
A6B259KLW	20-lead SOIC	70°C/W	17°C/W





Dwg. GS-004A



#### **FUNCTION TABLE**

CLEAR	Inputs ENABLE	DATA	Addressed OUTPUT	Other OUTPUTs	Function
Н	L	Н	L	R	Addressable
Н	L	L	Н	R	Latch
Н	Н	Х	R	R	Memory
L	L	Н	L	Н	8-Line
L	L	L	Н	Н	Demultiplexer
L	Н	Х	H	Н	Clear

#### L = Low Logic Level H = High Logic Level X = Irrelevant R = Previous State

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#### LOGIC SYMBOL

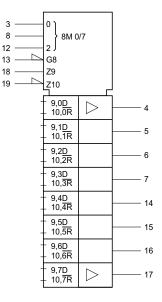
3

8

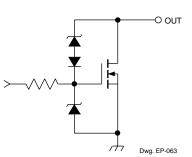
12

13

19



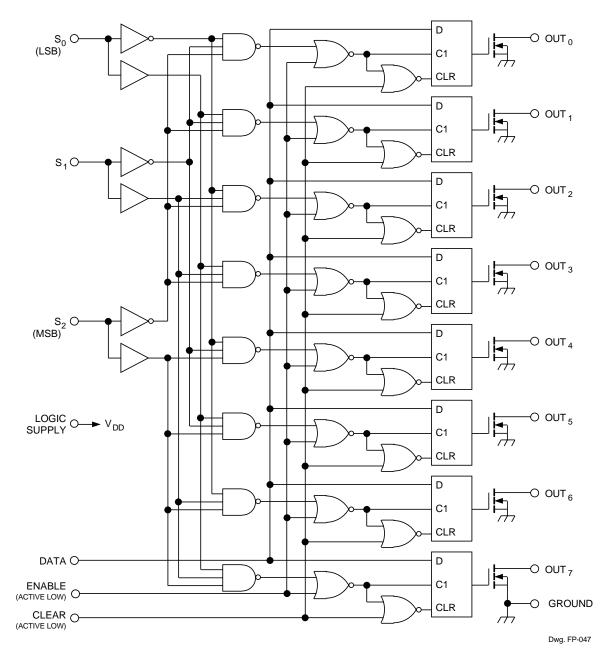
Dwg. FP-046



#### DMOS POWER DRIVER OUTPUT

#### LATCH SELECTION TABLE

Sele	Addressed		
S <sub>2</sub> (MSB)	$S_1$	S <sub>0</sub> (LSB)	OUTPUT
L	L	L	0
L	L	Н	1
L	Н	L	2
L	Н	Н	3
н	L	L	4
н	L	Н	5
н	Н	L	6
Н	Н	Н	7



#### FUNCTIONAL BLOCK DIAGRAM

Grounds (terminals 9, 10, and 11) must be connected externally to a single point.

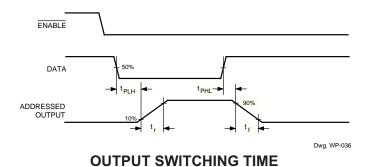
# ELECTRICAL CHARACTERISTICS at T<sub>A</sub> = +25°C, V<sub>DD</sub> = 5 V, t<sub>ir</sub> = t<sub>if</sub> $\leq$ 10 ns (unless otherwise specified).

				Limits			
Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Units	
Logic Supply Voltage	V <sub>DD</sub>	Operating	4.5	5.0	5.5	V	
Output Breakdown Voltage	V <sub>(BR)DSX</sub>	I <sub>O</sub> = 1 mA	50			V	
Off-State Output	I <sub>DSX</sub>	$V_{O} = 40 \text{ V}, \text{ V}_{DD} = 5.5 \text{ V}$		0.1	5.0	μΑ	
Current		$V_{O} = 40 \text{ V}, \text{ V}_{DD} = 5.5 \text{ V}, \text{ T}_{A} = 125^{\circ}\text{C}$		0.15	8.0	μA	
Static Drain-Source	r <sub>DS(on)</sub>	I <sub>O</sub> = 100 mA, V <sub>DD</sub> = 4.5 V		4.2	5.7	Ω	
On-State Resistance		$I_{O}$ = 100 mA, $V_{DD}$ = 4.5 V, $T_{A}$ = 125°C		6.8	9.5	Ω	
		$I_{O}$ = 350 mA, $V_{DD}$ = 4.5 V (see note)		5.5	8.0	Ω	
Nominal Output Current	I <sub>ON</sub>	V <sub>DS(on)</sub> = 0.5 V, T <sub>A</sub> = 85°C		90		mA	
Logic Input Current	I <sub>IH</sub>	V <sub>I</sub> = V <sub>DD</sub> = 5.5 V			1.0	μA	
	I	V <sub>I</sub> = 0, V <sub>DD</sub> = 5.5 V	_		-1.0	μΑ	
Prop. Delay Time	t <sub>PLH</sub>	I <sub>O</sub> = 100 mA, C <sub>L</sub> = 30 pF		150	_	ns	
	t <sub>PHL</sub>	I <sub>O</sub> = 100 mA, C <sub>L</sub> = 30 pF		90	_	ns	
Output Rise Time	t <sub>r</sub>	I <sub>O</sub> = 100 mA, C <sub>L</sub> = 30 pF		200	_	ns	
Output Fall Time	t <sub>f</sub>	I <sub>O</sub> = 100 mA, C <sub>L</sub> = 30 pF		200	—	ns	
Supply Current	I <sub>DD(OFF)</sub>	$V_{DD}$ = 5.5 V, Outputs off		20	100	μΑ	
	I <sub>DD(ON)</sub>	V <sub>DD</sub> = 5.5 V, Outputs on		150	300	μA	

Typical Data is at  $V_{DD} = 5$  V and is for design information only.

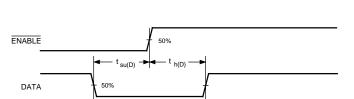
NOTE — Pulse test, duration  $\leq 100 \,\mu$ s, duty cycle  $\leq 2\%$ .





#### FUNCTIONAL DESCRIPTION and INPUT REQUIREMENTS

Dwg. WP-037



#### DATA INPUT REQUIREMENTS

Data Active Time Before Enable	
(Data Set-Up Time), t <sub>su(D)</sub>	20 ns
Data Active Time After Enable	
(Data Hold Time), t <sub>h(D)</sub>	20 ns
Data Pulse Width, t <sub>w(D)</sub>	40 ns
Input Logic High, $V_{IH}$ $\geq$ 0.8	5V <sub>CC</sub>
Input Logic Low, $V_{IL}$ $\leq 0.1$	5V <sub>CC</sub>

Four modes of operation are selectable by controlling the CLEAR and ENABLE inputs as shown above.

In the addressable-latch mode, data at the DATA input is written into the addressed transparent latch. The addressed output inverts the data input with all other outputs remaining in their previous states.

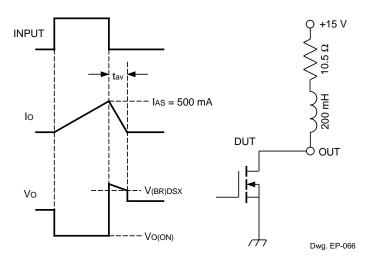
In the memory mode, all outputs remain in their previous states and are unaffected by the DATA or address  $(S_n)$  inputs. To prevent entering erroneus data in the latches, ENABLE should be held HIGH while the address lines are changing.

In the demultiplexing/decoding mode, the addressed output inverts the data input and all other outputs are OFF.

In the clear mode, all outputs are OFF and are unaffected by the DATA or address  $(S_N)$  inputs.

Given the appropriate inputs, when DATA is LOW for a given address, the output is OFF; when DATA is HIGH, the output is ON and can sink current.

#### **TEST CIRCUITS**



 $E_{AS} = I_{AS} \times V_{(BR)DSX} \times t_{AV}/2$ 

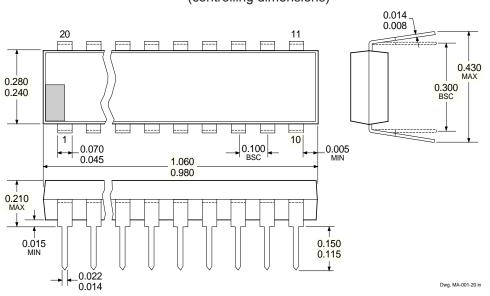
### Single-Pulse Avalanche Energy Test Circuit and Waveforms



Terminal No.	Terminal Name	Function
1	NC	No (internal) connection.
2	LOGIC SUPPLY	$(V_{DD})$ The logic supply voltage (typically 5 V).
3	$S_0$	Binary-coded output-select input, least-significant bit.
4	OUT <sub>0</sub>	Current-sinking, open-drain DMOS output, address 000.
5	OUT <sub>1</sub>	Current-sinking, open-drain DMOS output, address 001.
6	OUT <sub>2</sub>	Current-sinking, open-drain DMOS output, address 010.
7	OUT <sub>3</sub>	Current-sinking, open-drain DMOS output, address 011.
8	$\mathbf{S}_1$	Binary-coded output-select input.
9	LOGIC GROUND	Reference terminal for logic voltage measurements.
10	POWER GROUND	Reference terminal for output voltage measurements (OUT <sub>0-3</sub> ).
11	POWER GROUND	Reference terminal for output voltage measurements (OUT <sub>4-7</sub> ).
12	$S_2$	Binary-coded output-select input, most-significant bit.
13	ENABLE	Mode control input; see Function Table.
14	$OUT_4$	Current-sinking, open-drain DMOS output, address 100.
15	OUT <sub>5</sub>	Current-sinking, open-drain DMOS output, address 101.
16	OUT <sub>6</sub>	Current-sinking, open-drain DMOS output, address 110.
17	OUT <sub>7</sub>	Current-sinking, open-drain DMOS output, address 111.
18	DATA	CMOS data input to the addressed output latch. When enabled, the addressed output inverts the data input (DATA = HIGH, OUTPUT = LOW).
19	CLEAR	Mode control input; see Function Table.
20	NC	No (internal) connection.

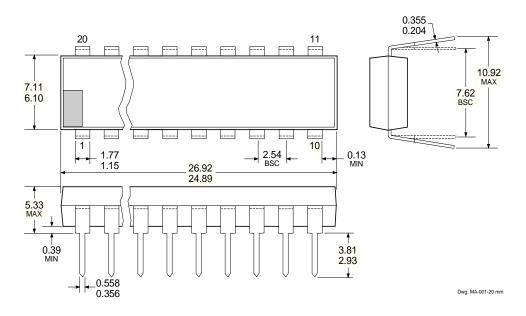
### **TERMINAL DESCRIPTIONS**

NOTE — Grounds (terminals 9, 10, and 11) must be connected externally to a single point.



A6B259KA Dimensions in Inches (controlling dimensions)

Dimensions in Millimeters (for reference only)

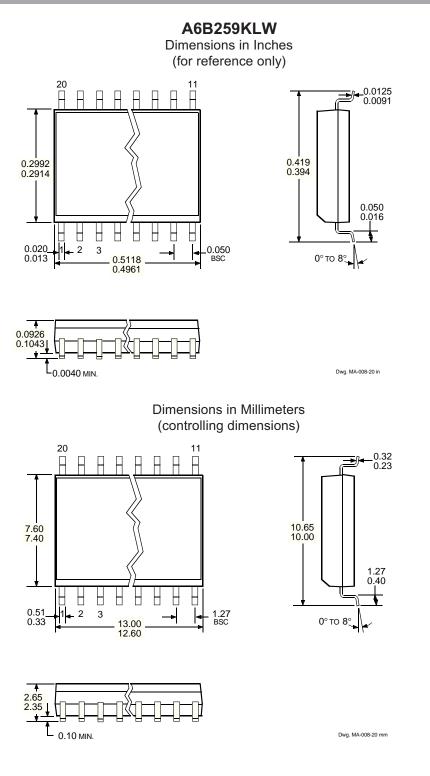


NOTES: 1. Exact body and lead configuration at vendor's option within limits shown.

- 2. Lead spacing tolerance is non-cumulative.
- 3. Lead thickness is measured at seating plane or below.



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NOTES: 1. Exact body and lead configuration at vendor's option within limits shown. 2. Lead spacing tolerance is non-cumulative.

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